Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/719,302	JAROFF, JOSEPH	
Examiner	Art Unit	_
José V. Chen	3637	

	SEARCHED			
Class	Subclass	Date	Examiner	
108	5001	7 /13/07	N	
	108			
-0.6	152			
294	338		•	
298	16/			
	407			
	157			
	423			

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
For of Bock	7/B/A	N		
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